

## UNITED STATES PATENT AND TRADEMARK OFFICE

UNITED STATES DEPARTMENT OF COMMERCE United States Patent and Trademark Office Address: COMMISSIONER FOR PATENTS P.O. Box 1450 Alexandria, Virginia 22313-1450 www.uspto.gov

APPLICATION NO. FILING DATE		FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.			
10/751,108 01/05/2004		Richard William Earnshaw	550-506	1346			
23117	7590	01/18/2006		EXAMINER			
		RHYE, PC	WHITMORE, STACY				
901 NORTH ARLINGTO		ROAD, 11TH FLO 22203	OOR	ART UNIT	PAPER NUMBER		
				2825			
				DATE MAILED: 01/18/2006	DATE MAILED: 01/18/2006		

Please find below and/or attached an Office communication concerning this application or proceeding.

		App	lication No.	Applicant(s)	pplicant(s)				
		10/7	751,108	EARNSHAW E	ET AL.	A			
	Office Action Summary	Exa	miner	Art Unit		1			
		Stac	y A. Whitmore	2825		\			
Period fo	The MAILING DATE of this commun or Reply	nication appears o	on the cover sheet	with the correspondence	address -				
WHIC - Exte after - If NC - Failu Any	ORTENED STATUTORY PERIOD FOR CHEVER IS LONGER, FROM THE MISSIONS OF THE MISSIO	MAILING DATE C s of 37 CFR 1.136(a). In munication. tatutory period will apply y will, by statute, cause t	OF THIS COMMUI in no event, however, may or and will expire SIX (6) M whe application to become	NICATION. If a reply be timely filed  ONTHS from the mailing date of the ABANDONED (35 U.S.C. § 133).	nis communic				
Status									
1)🖂	Responsive to communication(s) fil	ed on <i>05 Januar</i> o	/ 2004						
·	•								
3)									
ت ره	closed in accordance with the practice under <i>Ex parte Quayle</i> , 1935 C.D. 11, 453 O.G. 213.								
Disposit	ion of Claims	ZA PUI	o quayio, roco c						
· _		annliaation							
4)[	Claim(s) <u>1-19</u> is/are pending in the	• •	m consideration						
εν□	4a) Of the above claim(s) is/are withdrawn from consideration.								
· · · · · · · · · · · · · · · · · · ·	Claim(s) is/are allowed.								
· —	· · · ———								
′=	· · · · · · · · · · · · · · · · · · ·								
8)∐	Claim(s) are subject to restri	ction and/or elect	non requirement.						
Applicat	ion Papers								
9)[	The specification is objected to by the	ne Examiner.							
10)🛛	The drawing(s) filed on 05 January	<u>2004</u> is/are: a)⊠	accepted or b)	objected to by the Exar	niner.				
	Applicant may not request that any object	ection to the drawin	ıg(s) be held in abey	/ance. See 37 CFR 1.85(a	<b>)</b> .				
	Replacement drawing sheet(s) including	g the correction is r	required if the drawi	ng(s) is objected to. See 37	7 CFR 1.12	21(d).			
11)	The oath or declaration is objected to	o by the Examine	er. Note the attach	ned Office Action or form	PTO-152	2.			
Priority (	ınder 35 U.S.C. § 119								
a)l	Acknowledgment is made of a claim  All b) Some * c) None of:  1. Certified copies of the priority  2. Certified copies of the priority  3. Copies of the certified copies application from the Internations  See the attached detailed Office actions	or documents have or documents have of the priority do onal Bureau (PC	e been received. e been received ir cuments have be T Rule 17.2(a)).	n Application No. <u>09/328,</u> en received in this Nation					
2) 🔲 Notic 3) 🔯 Infori	t(s) e of References Cited (PTO-892) e of Draftsperson's Patent Drawing Review ( mation Disclosure Statement(s) (PTO-1449 o r No(s)/Mail Date <u>6/7/2004</u> .		Paper N	w Summary (PTO-413) lo(s)/Mail Date of Informal Patent Application (	PTO-152)				

Application/Control Number: 10/751,108

Art Unit: 2825

## **DETAILED ACTION**

Page 2

## Claim Rejections - 35 USC § 102

The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless –

- (e) the invention was described in (1) an application for patent, published under section 122(b), by another filed in the United States before the invention by the applicant for patent or (2) a patent granted on an application for patent by another filed in the United States before the invention by the applicant for patent, except that an international application filed under the treaty defined in section 351(a) shall have the effects for purposes of this subsection of an application filed in the United States only if the international application designated the United States and was published under Article 21(2) of such treaty in the English language.
- 1. Claims 1-3, 5-7, 10, 12-13, 15, and 18-19 are rejected under 35 U.S.C. 102(e) as being anticipated by Baxter (US Patent 6,018,624).
- 2. As for the claims Baxter discloses the invention as claimed, including:
- 1. and 19 (Original) A method (and apparatus for) of modeling an integrated circuit, said method comprising the steps of :
- (i) generating (memory for storing) a circuit component model including signal transitions with a set of associated delays and rules for a given implementation of said integrated circuit [abstract; PLD simulation model; timing characteristics; col. 2, line 41 col. 3, line 13; col. 4, lines 11-42; rules are part of the circuit description and PLD simulation model ];

Art Unit: 2825

(ii) (a delay calculator) calculating signal delays for signal transitions within said circuit component model using a delay calculator and a subset of said set of associated delays and rules [col. 2, line 41 – col. 3, line 13]; and

- (iii) searching said circuit component model to identify signal transitions corresponding to signal transitions with associated signal delays as calculated by said delay calculator [col. 2, line 41 col. 3, line 13]; and
- (iv) (modifying logic for) modifying said circuit component model for identified matching signal transitions with said delays calculated by said delay calculator and said set of associated delays and rules [abstract; col. 2, line 41 col. 3, line 13; the new simulation model is generated and based on matching].
- 2. (Original) A method as claimed in claim 1, wherein if said searching does not identify a matching signal relationship within said circuit component model for a signal transition and delay calculated by said delay calculator, then said signal transition and delay is passed directly to said circuit component model [col. 2, line 41 col. 3, line 13].
- 3. (Original) A method as claimed in claim 1, wherein said integrated circuit includes a macrocell which is modeled within said circuit component model other than by a details of individual circuit components [col. 11, lines 32-36].
- 5. (Original) A method as claimed in claim 1, wherein, if said circuit component model includes a plurality of a signal transitions that match a signal transition and delay calculated by said delay calculator, then said signal transition and delay calculated by said delay calculator is used to modify all of said plurality of signal transitions within said circuit component model [col. 2, line 41 col. 3, line 13].
- 6. (Original) A method as claimed in claim 1, wherein if said signal transitions and delays calculated by said delay calculator include a plurality of signal transitions and delays that match a signal transition within said circuit component model, then that signal transition and delay calculated by said delay calculator that most specifically matches said signal transition within said circuit component model is used to modify said signal transition within said circuit component model [col. 2, line 41 col. 3, line 13; col. 12, lines 35-39].
- 7. (Original) A method as claimed in claim 1, wherein if signal transitions and

Art Unit: 2825

delays calculated by said delay calculator include a signal transition and delay that is more specifically defined than any signal transition within said circuit component model, then the most specifically matching signal transition within said circuit component model is modified with said signal transition and delay [col. 2, line 41 – col. 3, line 13; col. 12, lines 35-39].

- 10. (Original) A method as claimed in claim 1, wherein said set of associated delays and rules within said circuit component model includes associated condition parameters and said signal transitions and delays calculated by said delay calculator do not include condition parameters [col. 11, lines 13-31].
- 12. (Original) A method as claimed in claim 10, wherein modified delay values for all of said condition parameters are inferred from said calculated delay using relative differences between said delays within said circuit component model [col. 2, line 41 col. 3, line 13; col. 12, lines 35-39].
- 13. (Currently Amended) A method as claimed in claim 1, wherein at least one of said associated set of delays and rules includes edge direction parameters [col. 11, lines 18-20, edge direction may be the hold or setup due to the hold and setup being associated with the direction of the edge of a signal].
- 15. (Original) A method as claimed in claim 1, wherein said circuit component model is a netlist model with associated timing and rule data [col. 2, netlist model].
- 18. (Original) A method as claimed in claim 1, wherein said step of modifying is responsive to constraint data specifying instructions for how said modification should be performed [col. 6, lines 59-66].

## Claim Rejections - 35 USC § 103

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made

Application/Control Number: 10/751,108

Art Unit: 2825

to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

- 3. Claim 4,8-9, 12, 14, 16, and 17 are rejected under 35 U.S.C. 103(a) as being unpatentable over Baxter (US Patent 6,018,624) in view of Earnshaw, R., et al., "Challenges in Cross-development".
- 4. As for the claims, Baxter discloses the invention substantially as claimed, including the method and apparatus for modeling an integrated circuit and cited above in the rejection of claims 1, 3, 7, 10, 15, and 19.

Baxter does not specifically disclose

- 4. (Original) A method as claimed in claim 3, wherein said macrocell is a microprocessor core.
- 8. (Original) A method as claimed in claim 1, further comprising the step of generating an audit log representing the steps taken.
- 9. (Original) A method as claimed in claim 7, further comprising the step of generating an audit log representing the steps taken and wherein said modification of said most specifically matching signal transition within said circuit component model with said more specifically defined signal transition and delay is recorded in said audit log.
- 14. (Original) A method as claimed claim 1, wherein said delay calculator outputs results as a standard delay format file [].
- 16. (Original) A method as claimed in claim 15, wherein said associated timing and rule data is a standard delay format file.
- 17. (Original) A method as claimed in claim 16, wherein said step of modifying modifies said standard delay format file.

Earnshaw discloses wherein said macrocell is a microprocessor core [pg. 33, left hand side – The ARMulation framework section – ARM processor core]; the step of

Application/Control Number: 10/751,108 Page 6

Art Unit: 2825

generating an audit log representing the steps taken [pg. 33, fig. 5, transaction control; pg. 34, left hand side discussion of transaction control]; the step of generating an audit log representing the steps taken and wherein said modification of said most specifically matching signal transition within said circuit component model with said more specifically defined signal transition and delay is recorded in said audit log [pg. 33, fig. 5, transaction control; pg. 34, left hand side discussion of transaction control]; and a standard delay format file [pg. 31, right hand side].

It would have been obvious to one of ordinary skill in the art at the time the invention was made to combine the teachings of Baxter and Earnshaw because utilizing Earnshaw's core, transaction control comprising an audit log, and SDF file would have provided Baxter's system with a single chip solution for a programmable device, and using standard files for debug (audit) and using a SDF for describing external and not internal signals for a processor core to provide a total single-chip package [see Earnshaw pg. 28 and 31].

- 5. Claim 11 is objected to as being dependent upon a rejected base claim, but would be allowable if rewritten in independent form including all of the limitations of the base claim and any intervening claims.
- 6. The following is a statement of reasons for the indication of allowable subject matter: The prior art of record fails to disclose either singularly or in combination a method of modeling a circuit comprising at least the step of wherein different condition parameters of a signal transition within said circuit component model have different delays associated with them and said delay calculator calculates a delay for only one condition parameter.
- 7. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Stacy A. Whitmore whose telephone number is (571)

Application/Control Number: 10/751,108 Page 7

Art Unit: 2825

272-1685. The examiner can normally be reached on Monday-Thursday, alternate Friday 6:30am - 4:00 pm.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Jack Chiang can be reached on (571) 272-7483. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

Stacy A Whitmore
Primary Examiner
Art Unit 2825

SAW